

Notice of References Cited		Application/Control No. 10/711,817	Applicant(s)/Patent Under Reexamination LIN ET AL.	
		Examiner Paul Nguyen-Ba	Art Unit 2176	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0054745	03-2004	Lee, Sung-Dae	709/206
	B	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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